

Characterization Facility Demonstrations, Thursday January 17 accompanying the workshop **Characterization Methods for Surfaces, Interfaces and Thin Films**

			Shepherd Labs Room
Morning demos, 9-12:00			#
Phi Versaprobe III XPS	Bing Luo		22
Bruker AXS D8 Discover XRD	Javier Garcia Barriocanal		8
Woollam spectroscopic ellipsometer	John Suddard-Bangsund		22
Bruker Nano Hysitron Triboindenter 980	Prof. Nate Mara's group		87
Omicron-LT UHV STM/STS	Geoff Rojas		76
Oxford-Asylum Cypher SPM	Asylum personnel		22
Bruker Nano Multimode 8 SPM with Intermodulation	Greg Haugstad		87
Afternoon demos, 1-4:00			
Phi Versaprobe III UPS	Geoff Rojas		22
NEC Pelletron IBA system	Greg Haugstad		202
Bruker AXS D8 Discover XRD	Javier Garcia Barriocanal		8
Bruker Nano Hysitron Triboindenter 980	Prof. Nate Mara's group		87
Oxford-Asylum Cypher SPM	Asylum personnel		22
WITec confocal Raman	Bing Luo		29A

